



MOTOROLA

MC10179

LOOK-AHEAD CARRY BLOCK

The MC10179 is a high speed, low power, standard MECL complex function that is designed to perform the look-ahead carry function. This device can be used with the MC10181 4-bit ALU directly, or with the MC10180 dual arithmetic unit in any computer, instrumentation or digital communication application requiring high speed arithmetic operation on long words.

When used with the MC10181, the MC10179 performs a second order or higher look-ahead. Figure 2 shows a 16-bit look-ahead carry arithmetic unit. Second order carry is valuable for longer binary words. As an example, addition of two 32-bit words is improved from 30 nanoseconds with ripple-carry techniques. A block diagram of a 32-bit ALU is shown in Figure 1. The MC10179 may also be used in many other applications. It can, for example, reduce system package count when used to generate functions of several variables.

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$P_D = 300 \text{ mW typ/pkg (No Load)}$

$t_{pd} = 3.0 \text{ ns typ (Carry, Propagate)}$

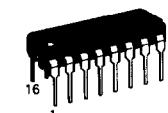
$4.0 \text{ ns typ (Generate)}$

$t_r, t_f = 2.3 \text{ ns typ (20\%-80\%)}$

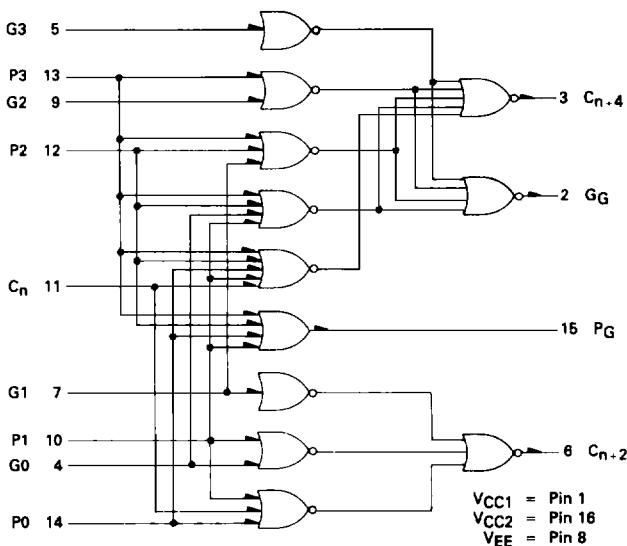
MECL 10K SERIES

LOOK-AHEAD CARRY BLOCK

P SUFFIX
PLASTIC PACKAGE
CASE 648



LOGIC DIAGRAM



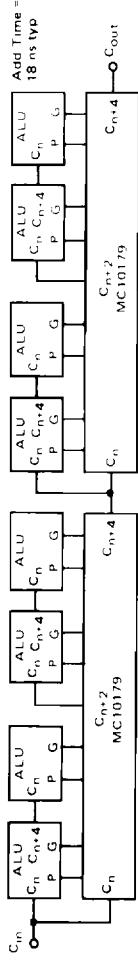
PIN ASSIGNMENT

VCC1	1	VCC2
GG	2	P _G
C _{n+4}	3	P ₀
G ₀	4	P ₃
G ₃	5	P ₂
C _{n+2}	6	C _n
G ₁	7	P ₁
VEE	8	G ₂

ELECTRICAL CHARACTERISTICS

Each MECL 10,000 series device has been designed to meet the dc specifications shown in the test table, after thermal equilibrium has been established. The circuit is in a test socket or mounted on a printed circuit board and transverse air flow greater than 500 linear fpm is maintained. Outputs are terminated through a 50-ohm resistor to -2.0 volts. Test procedures are shown only for selected inputs and outputs. Other inputs and outputs are tested in a similar manner.

TEST VOLTAGE VALUES (Volts)									
Temperature									
• Test	V _H max	V _L min	V _{THA} min	V _{TLA} max	V _{EE}				
-30°C	-0.890	-1.890	-1.205	-1.500	-5.2				
+25°C	-0.810	-1.850	-1.105	-1.475	-5.2				
+85°C	-0.700	-1.875	-1.035	-1.440	-5.2				
TEST VOLTAGE APPLIED TO PINS LISTED BELOW: (V _{CC}) Ground									
MC10179 Test Limits									
Pin									
Under T _{test}									
-30°C									
Min	79	58	72	79	79	Unit	V _H max	V _L min	V _{THA} min
Max	430	—	225	270	270	mA/dc	—	—	—
I _E	4.711	—	—	225	225	μA/dc	4.711	—	—
I _{inh}	5.9	—	—	440	5.9	—	—	—	—
I ₁₀₋₁₃	10.13	—	—	440	10.13	—	—	—	—
I ₁₂	12	—	—	395	12	—	—	—	—
I ₁₄	14	—	—	395	14	—	—	—	—
I _{int}	4	0.5	0.5	0.3	0.3	μA/dc	—	4	—
V _{OH}	2	-1.060	-0.890	-0.960	-0.810	V _{dc}	4.57.9	—	—
V _{OL}	3	-1.890	-1.675	-1.850	-1.650	-0.700	-1.615	V _{dc}	—
V _{OHA}	2	-1.080	—	-0.980	—	-0.910	—	5	—
V _{OHA}	2	—	—	—	—	—	—	9	—
V _{OHA}	2	—	—	—	—	—	—	12	—
V _{OHA}	2	—	—	—	—	—	—	13	—
V _{OVA}	2	—	-1.655	—	-1.630	V _{dc}	1.595	13	—
V _{OVA}	2	—	—	—	—	—	—	5	—
V _{OVA}	2	—	—	—	—	—	—	13	—
V _{OVA}	2	—	—	—	—	—	—	9	—
V _{OVA}	2	—	—	—	—	—	—	12	—
Sustaining Times (50% Level)									
t _{10-15*}	15	10	3.7	1.0	2.5	3.5	1.0	3.9	t ₅
t ₁₀₋₁₅₋	15	6	3.7	2.5	3.5	6.1	4.7	4.7	4.7
t ₁₁₊₆₊	6	—	5.8	—	3.0	5.5	—	—	4.7
t ₁₁₋₆₋	6	—	—	—	4.0	5.5	—	—	4.7
t ₅₊₂₊	2	—	—	—	4.0	5.5	—	—	4.7
t ₅₋₂₋	2	—	—	—	4.0	5.5	—	—	4.7
t ₅₊	6	1.1	3.7	1.1	2.5	3.5	1.1	3.9	4.7
t ₅₋	6	1.1	3.7	1.1	2.5	3.5	1.1	3.9	4.7
Propagation Delay									
t _R	—	—	—	—	—	—	—	—	—
Rise Time (20% to 80%)	—	—	—	—	—	—	—	—	—
Fall Time (20% to 80%)	—	—	—	—	—	—	—	—	—

FIGURE 1 — 32-BIT ALU WITH CARRY LOOK-AHEAD**FIGURE 2 — 16-BIT FULL LOOK-AHEAD CARRY ARITHMETIC LOGIC UNIT**